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Laboratory of Signal and Risk Analysis

Using Explanations to Identify Problems and Limitations in AI Models used for Intelligent Maintenance

Giovanni FLOREALE¹, Piero BARALDI¹, Enrico ZIO^{2,1}, Olga FINK³,

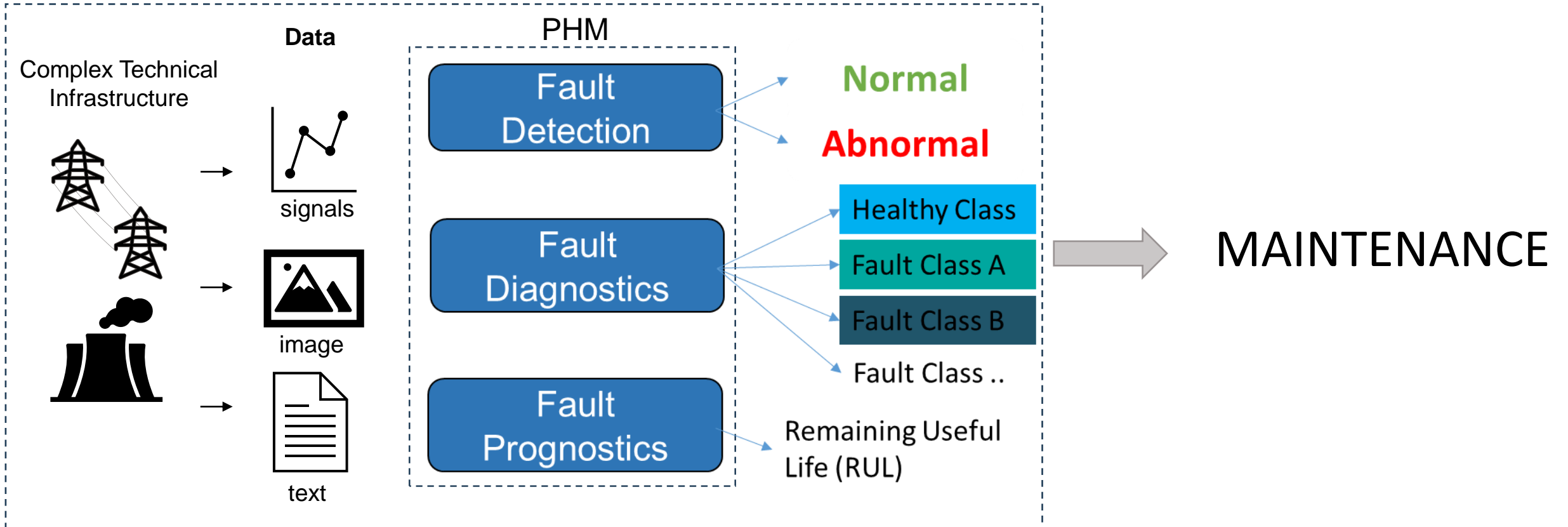
1 Department of Energy, Politecnico di Milano, Milan, Italy

2 MINES Paris-PSL University, Centre de Recherche sur les Risques et les Crises (CRC), Sophia Antipolis, France

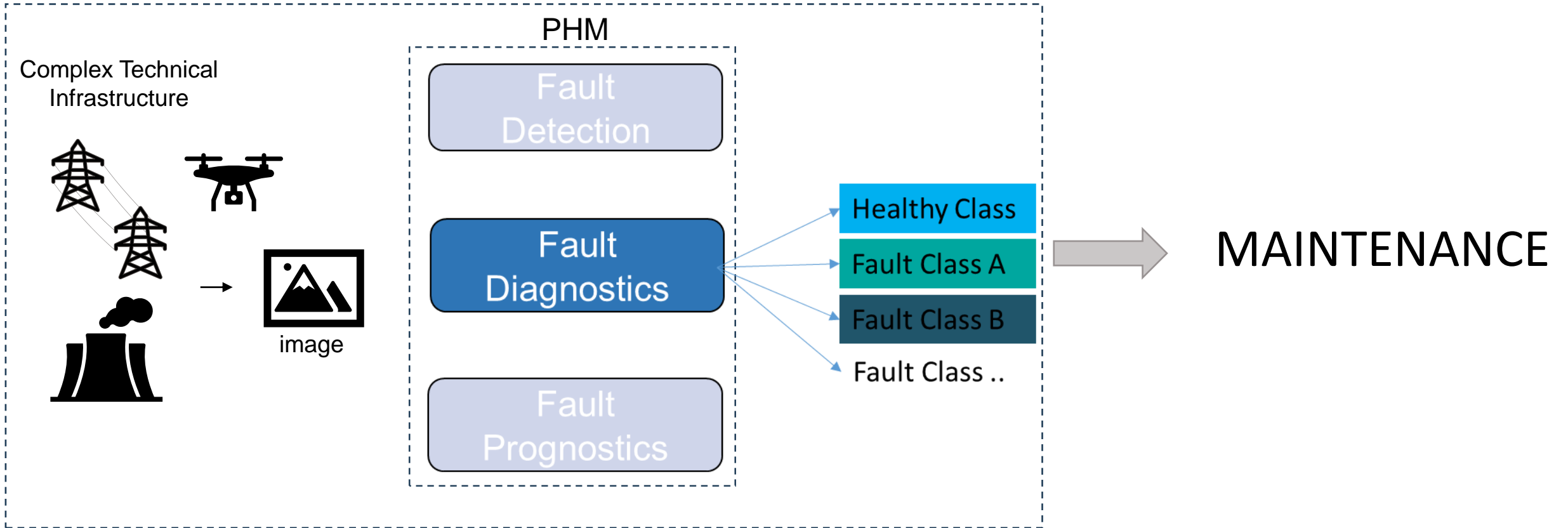
3 IMOS, EPFL, Lausanne, Switzerland

Lausanne, September 12th, 2023

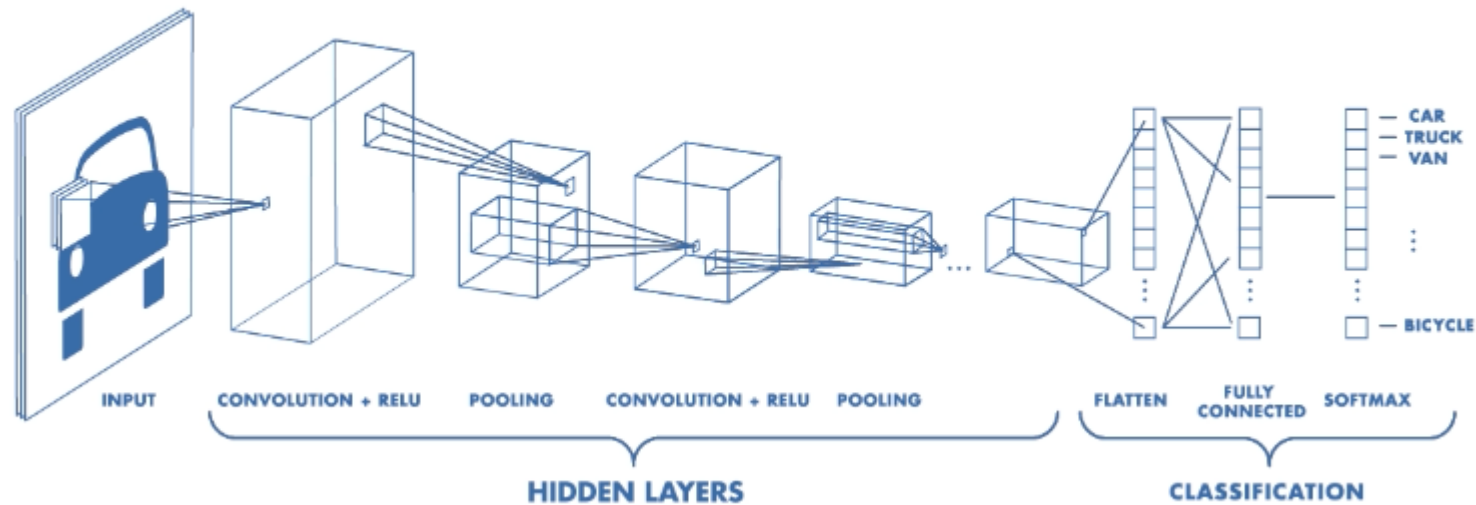
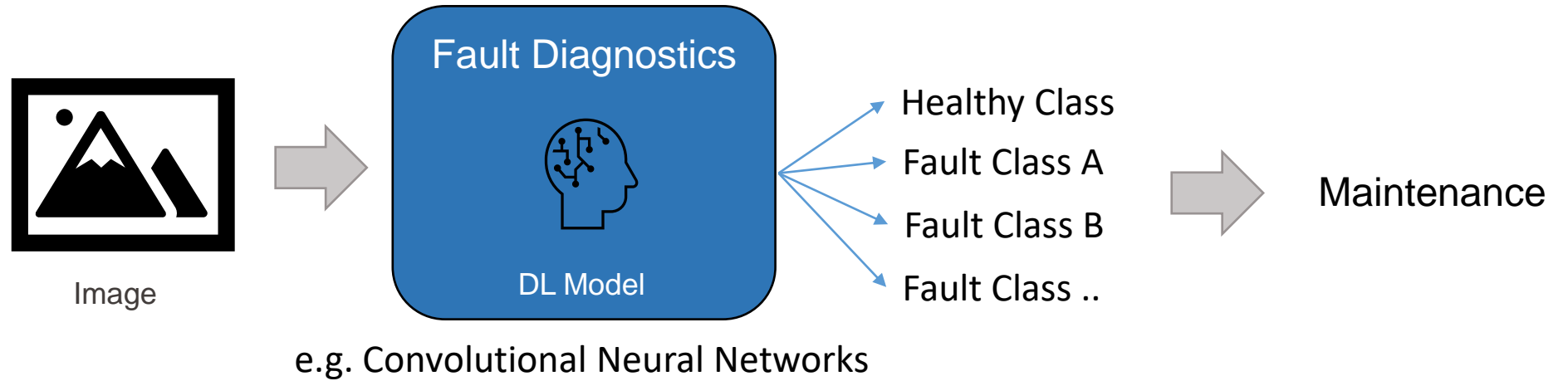
Context: What is the Problem?



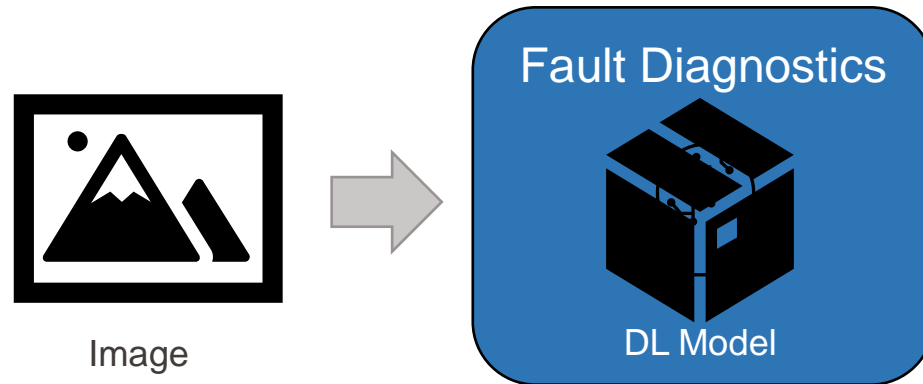
Context: What is the Problem?



How is Fault Diagnostics from Images done?



What are the Technical and Scientific Challenges?



Image

Fault Diagnostics

DL Model

Challenges:

- Black Box
- Performance



Classification Accuracy

Training set

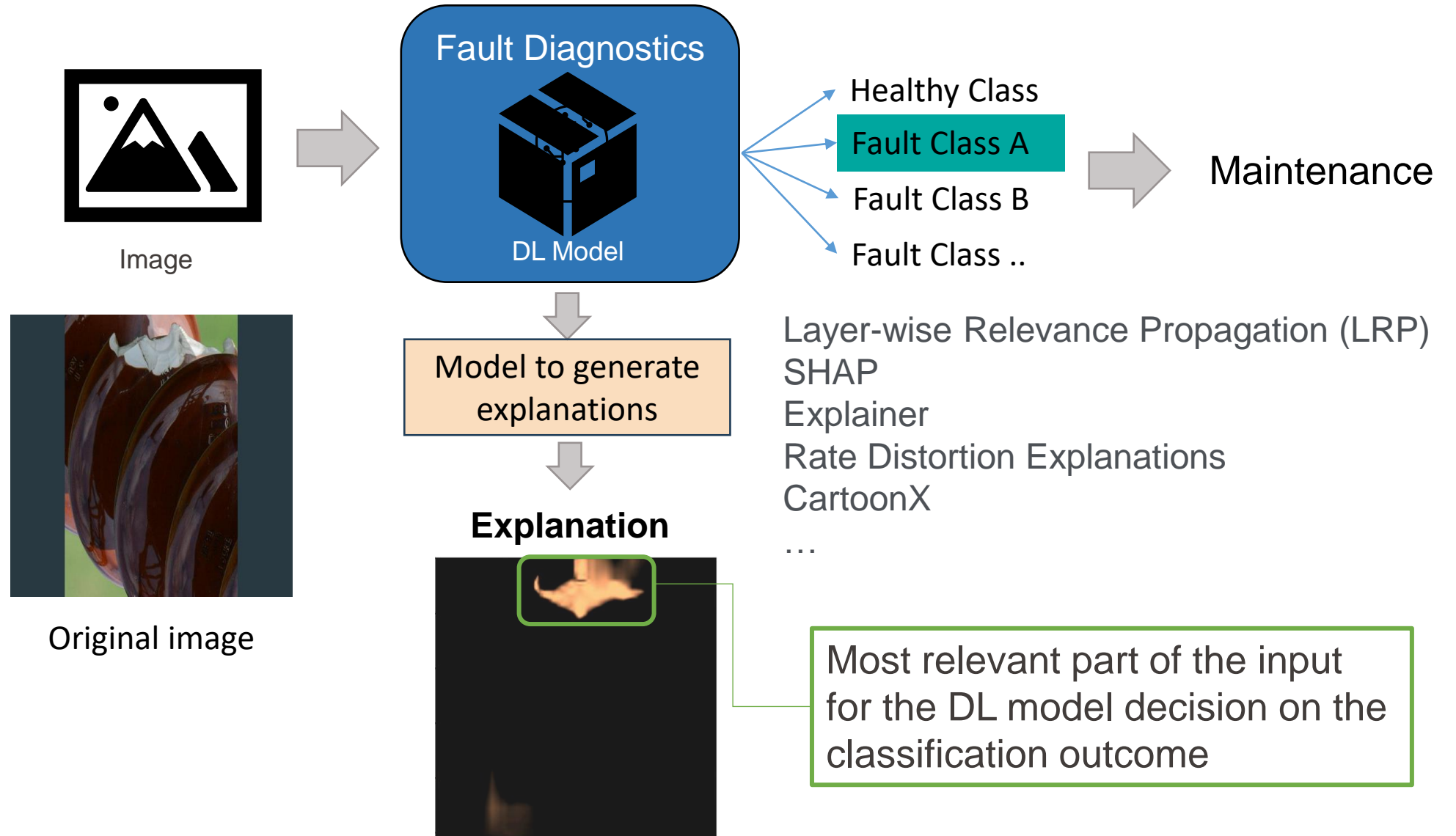
Test set

In field data

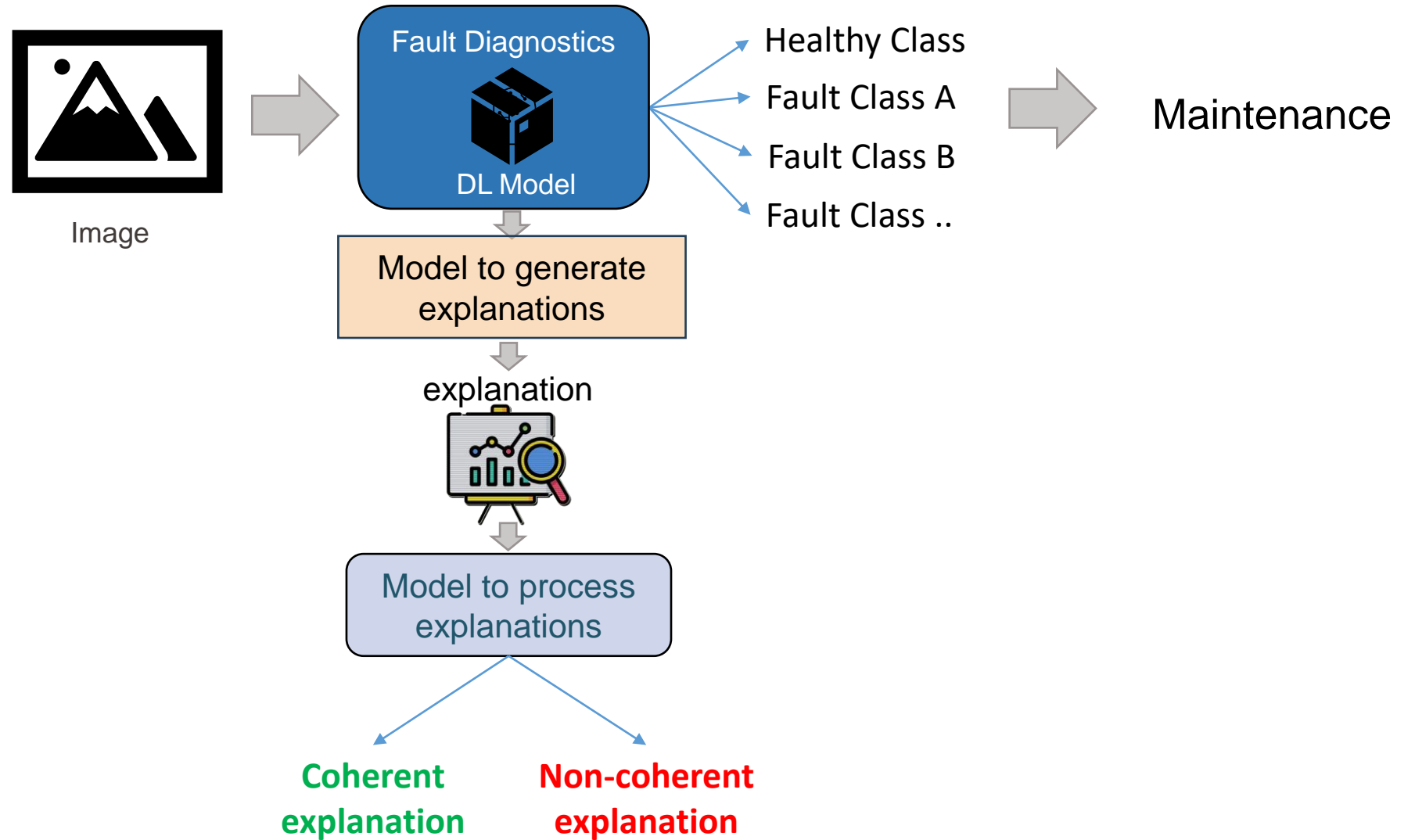
0



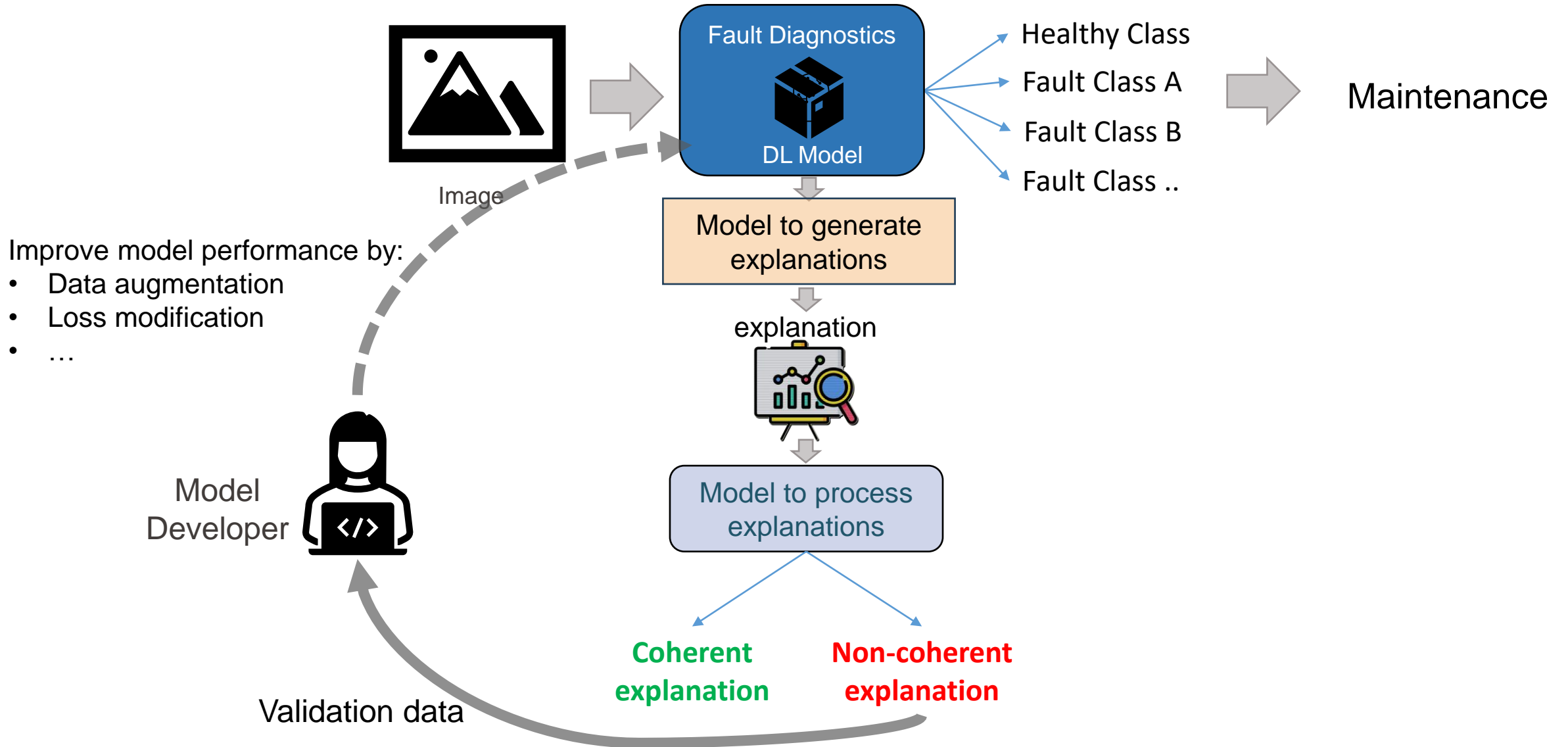
Opportunities: What Can Be Done?



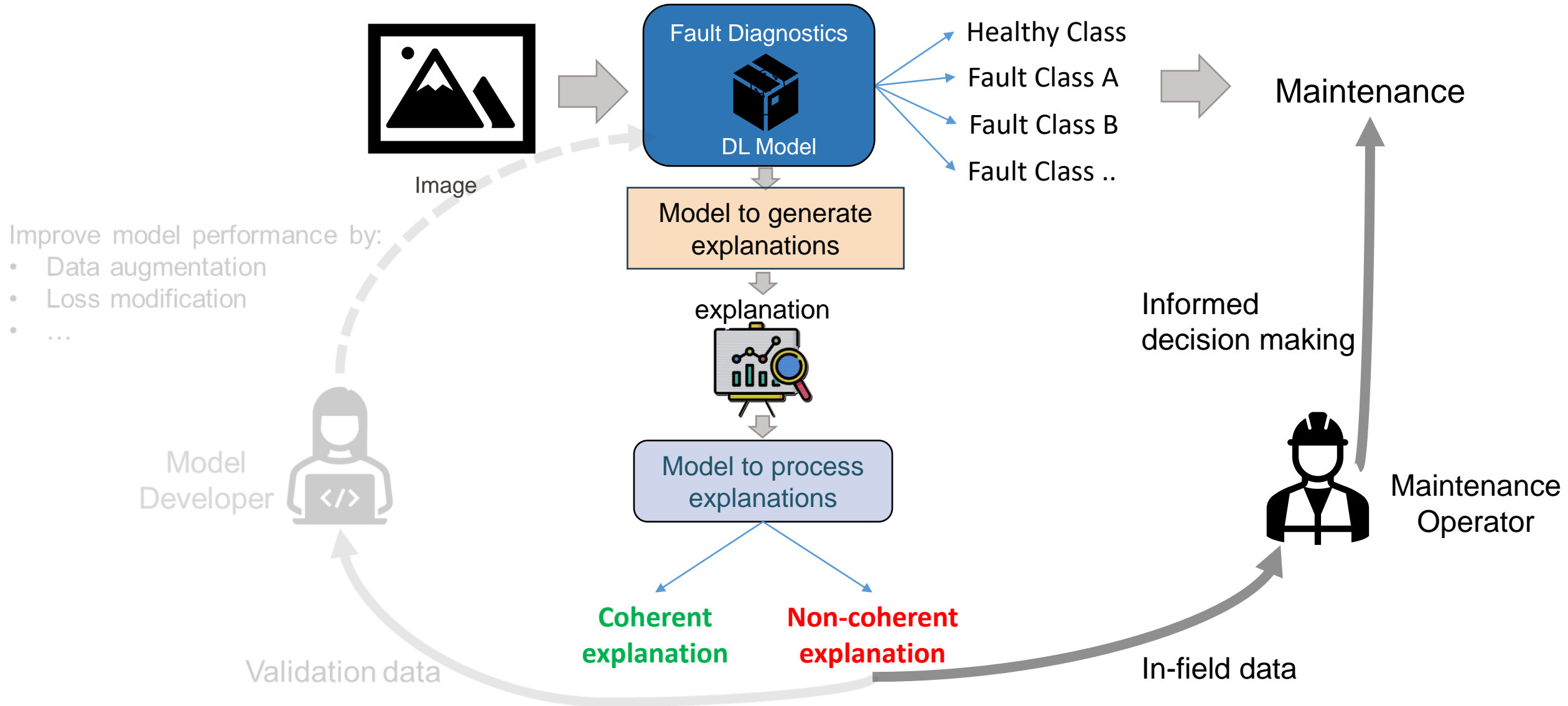
Objective: What are we Trying to Do?



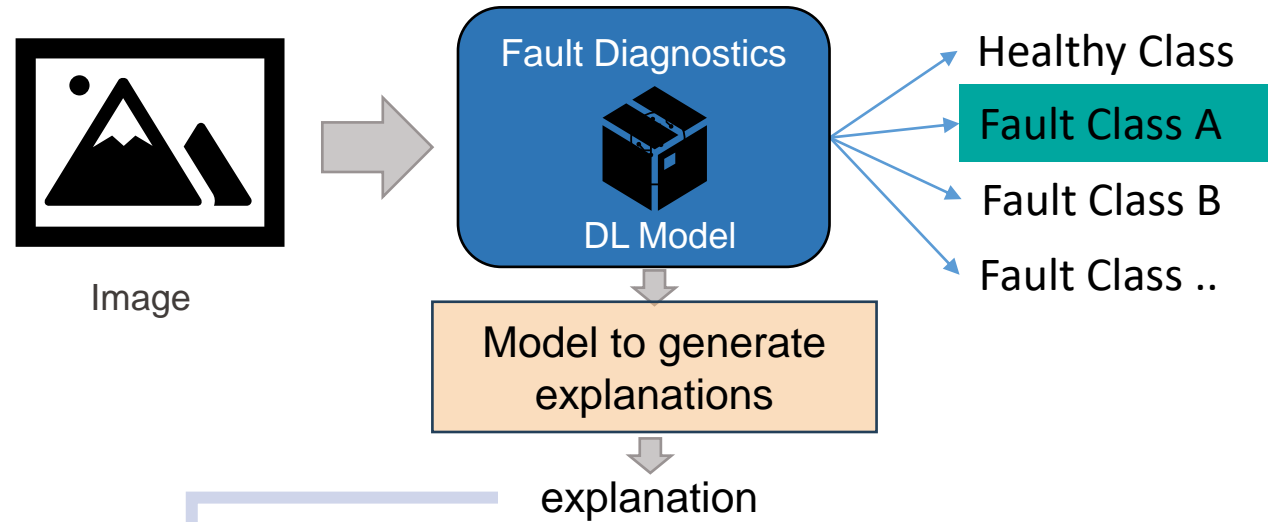
Relevance: Why is it Useful? (1)



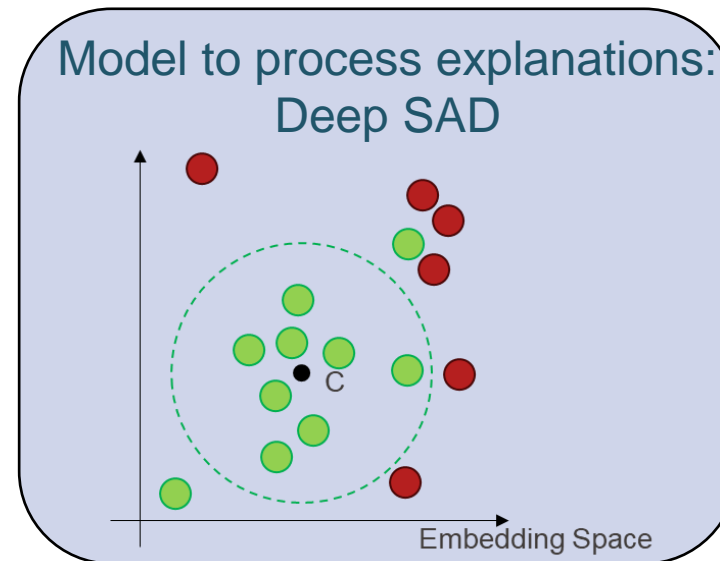
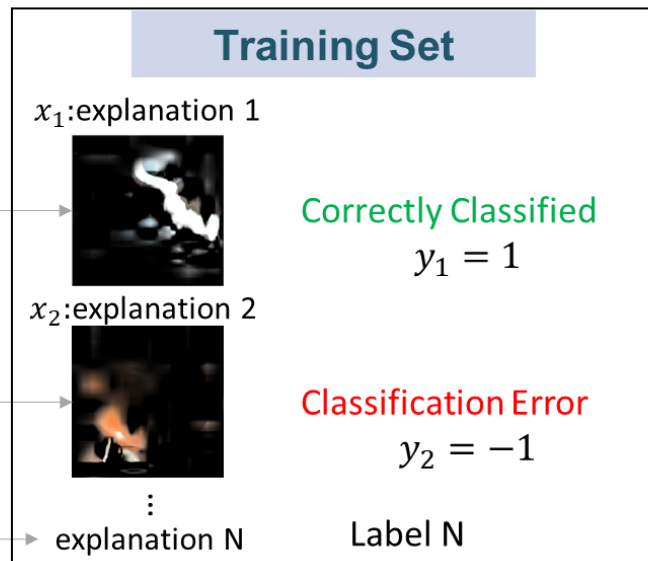
Relevance: Why is it Useful? (2)



Developed Method



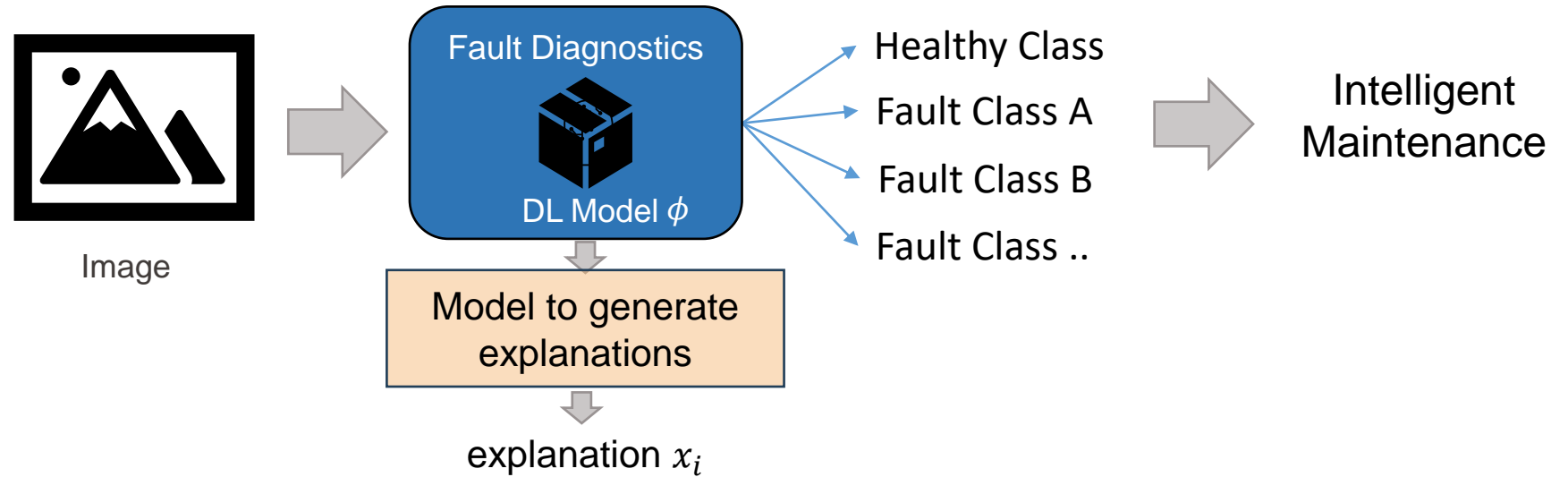
Select all the images assigned to one class



Non-coherent explanation

Coherent explanation

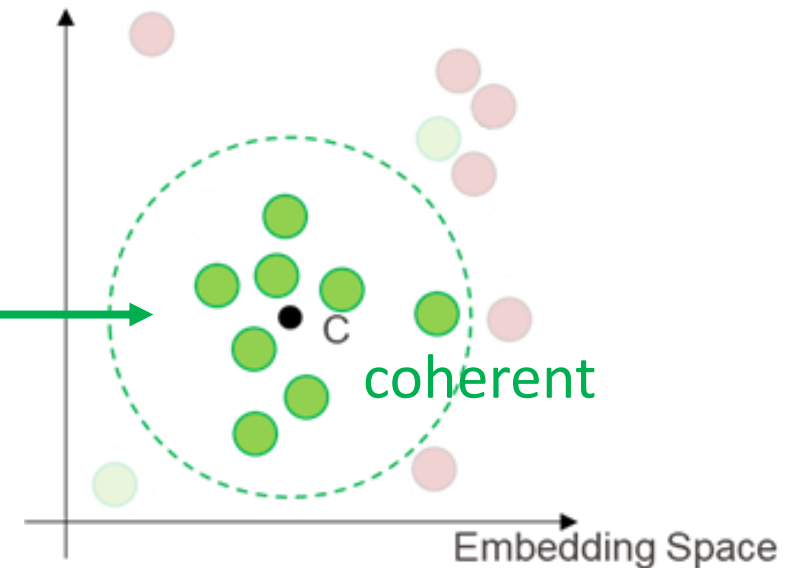
Developed Method



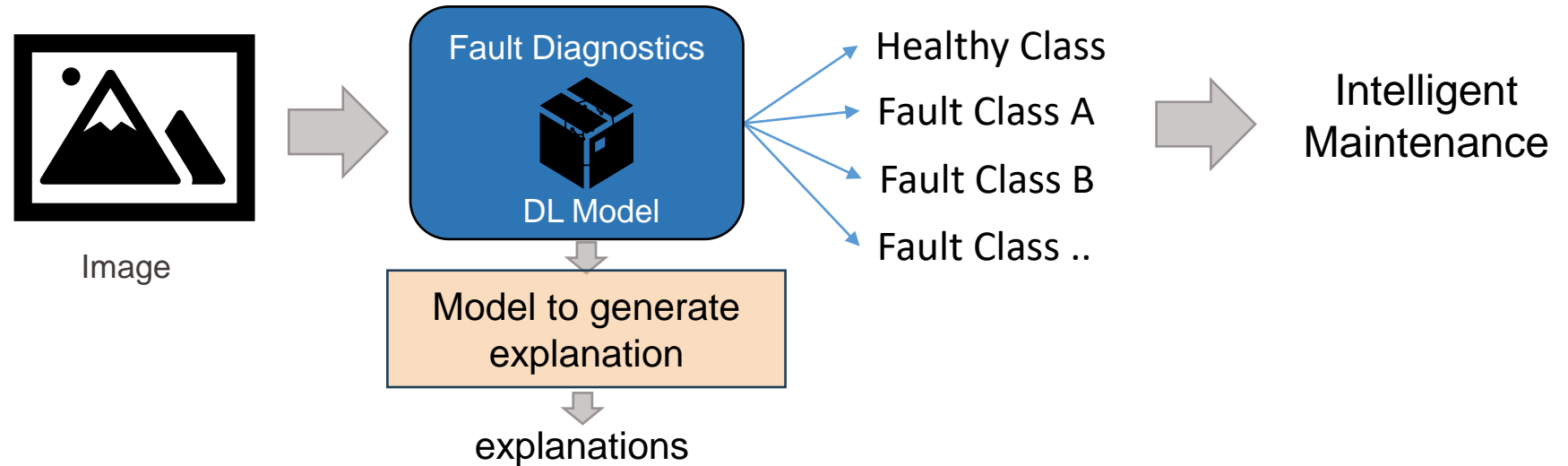
Embedding space definition: loss function

● Correct classifications:
minimize the distance from the centre

$$\min_{\mathcal{W}} \frac{1}{n+m} \sum_{i=1}^n \|\phi(x_i; \mathcal{W}) - c\|^2$$



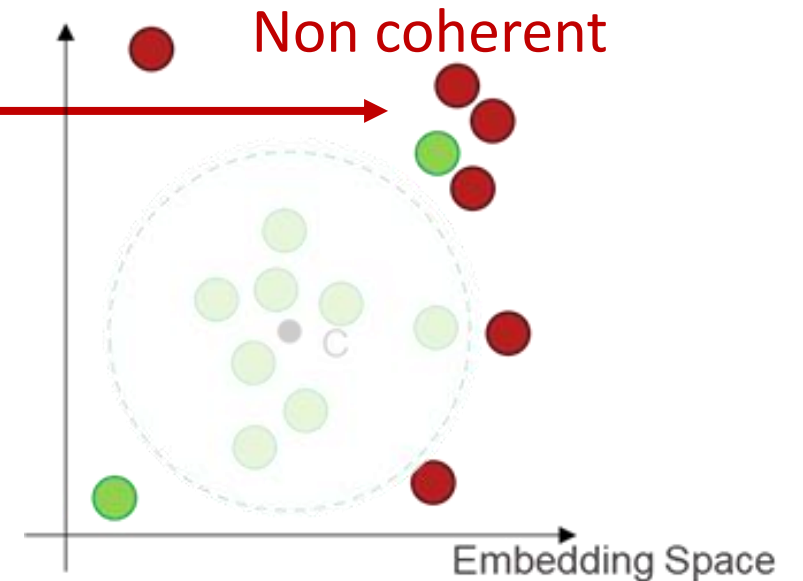
Developed Method



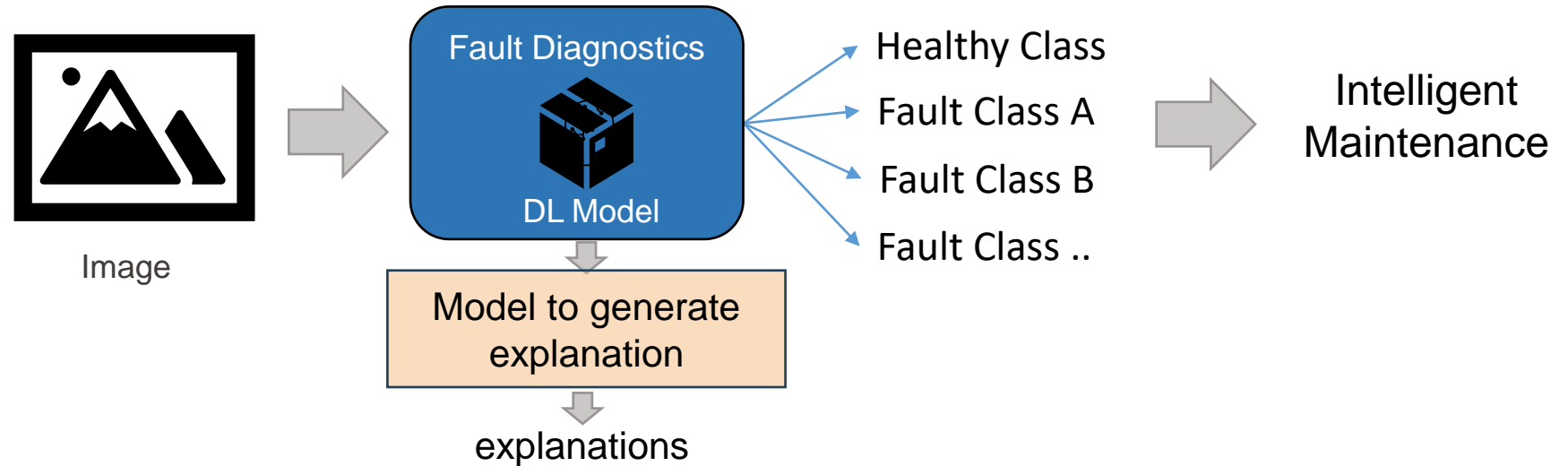
Embedding space definition: loss function

- Classifications errors: maximize the distance from the centre (hyperparameter η)

$$\min_{\mathcal{W}} \frac{1}{n+m} \sum_{i=1}^n \|\phi(x_i; \mathcal{W}) - c\|^2 + \frac{\eta}{n+m} \sum_{j=1}^m (\|\phi(\tilde{x}_j; \mathcal{W}) - c\|^2)^{\tilde{y}_j}$$



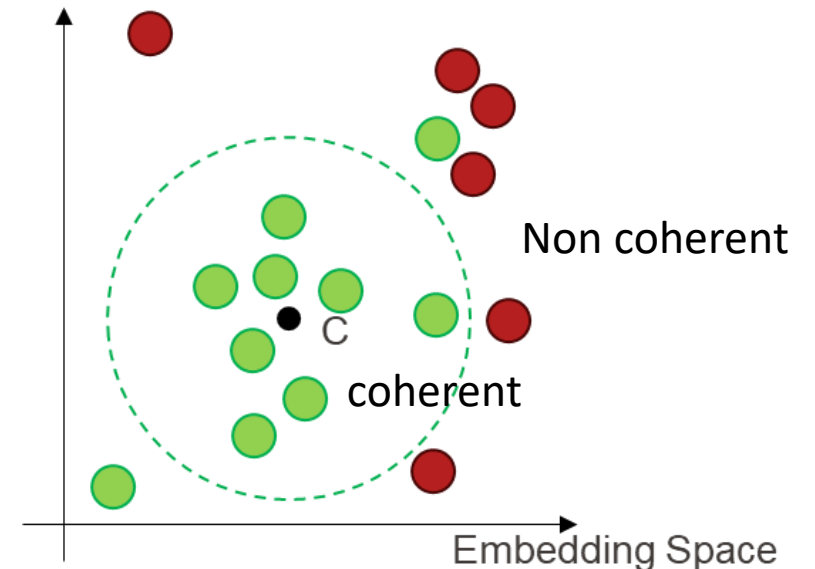
Developed Method



Embedding space definition: loss function

Regularization term to avoid overfitting
(hyperparameter λ)

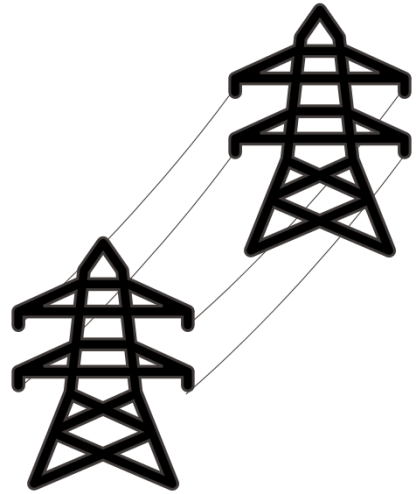
$$\min_{\mathcal{W}} \frac{1}{n+m} \sum_{i=1}^n \|\phi(x_i; \mathcal{W}) - c\|^2 + \frac{\eta}{n+m} \sum_{j=1}^m (\|\phi(\tilde{x}_j; \mathcal{W}) - c\|^2)^{\tilde{y}_j} + \frac{\lambda}{2} \sum_{\ell=1}^L \|\mathcal{W}^{\ell}\|_F^2.$$



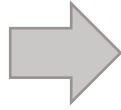
Case Study

Insulator Defect Image Dataset (IDID)

Dexter Lewis, Pratik Kulkarni, August 11, 2021, "Insulator Defect Detection", IEEE Dataport, doi: <https://dx.doi.org/10.21227/vkdw-x769.s>



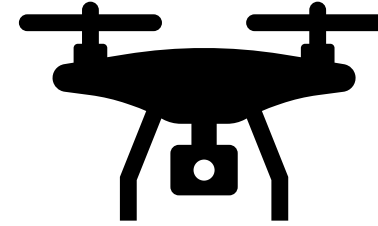
Power Grid



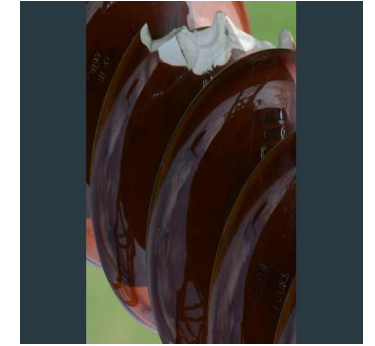
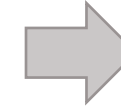
Critical Components:



Insulators



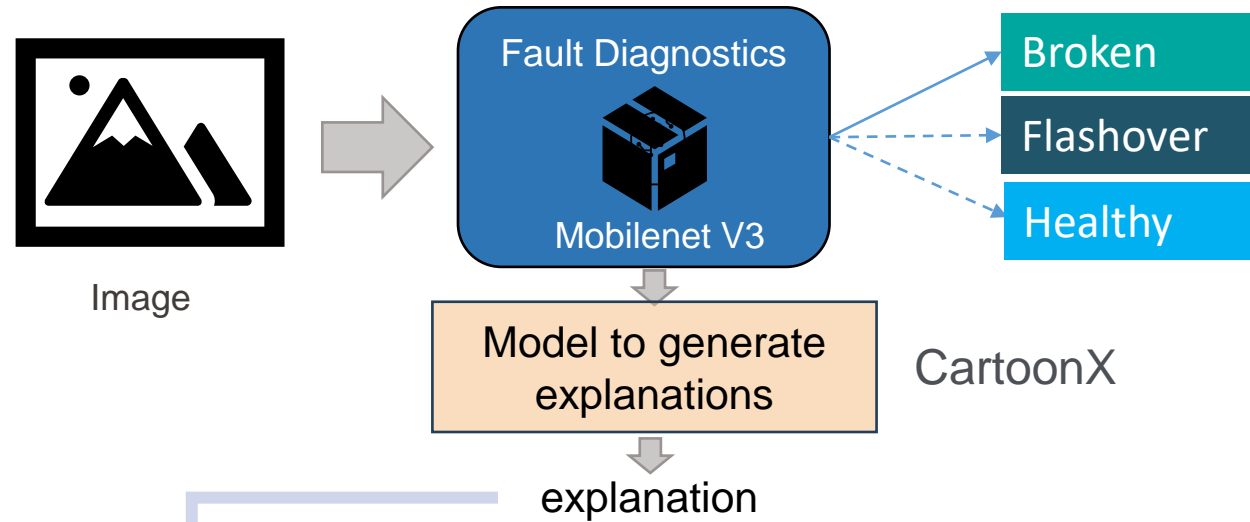
Drones



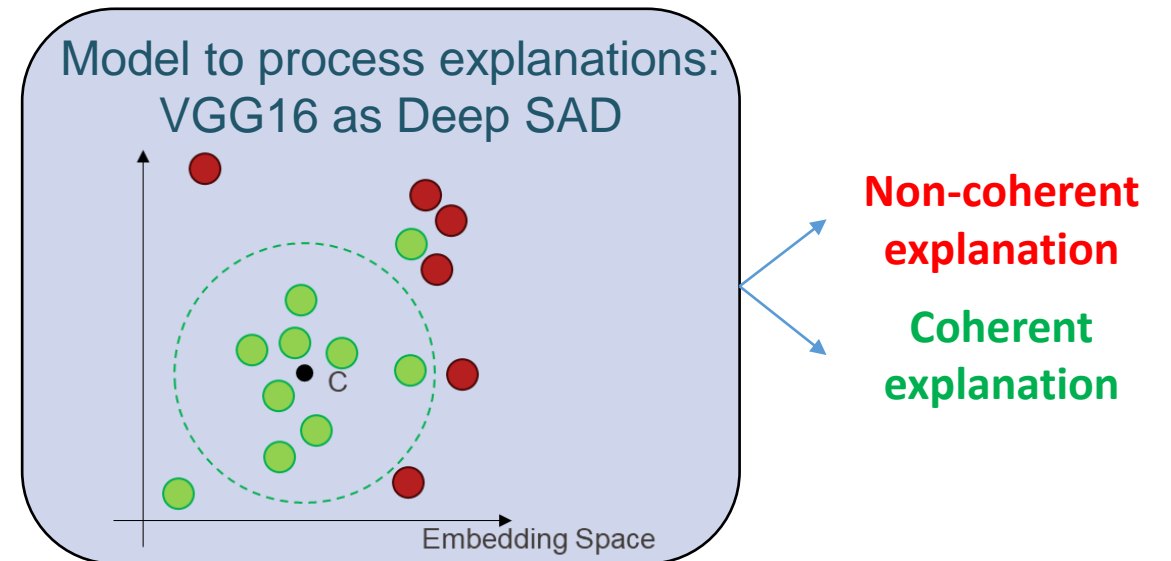
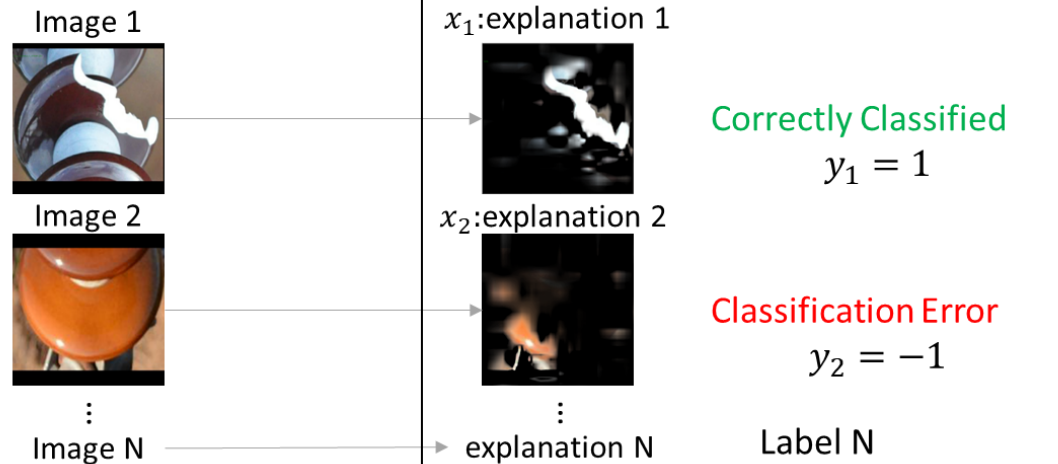
Shells' images

e.g. swiss power grid:
6700 km long → 12 000 pylons

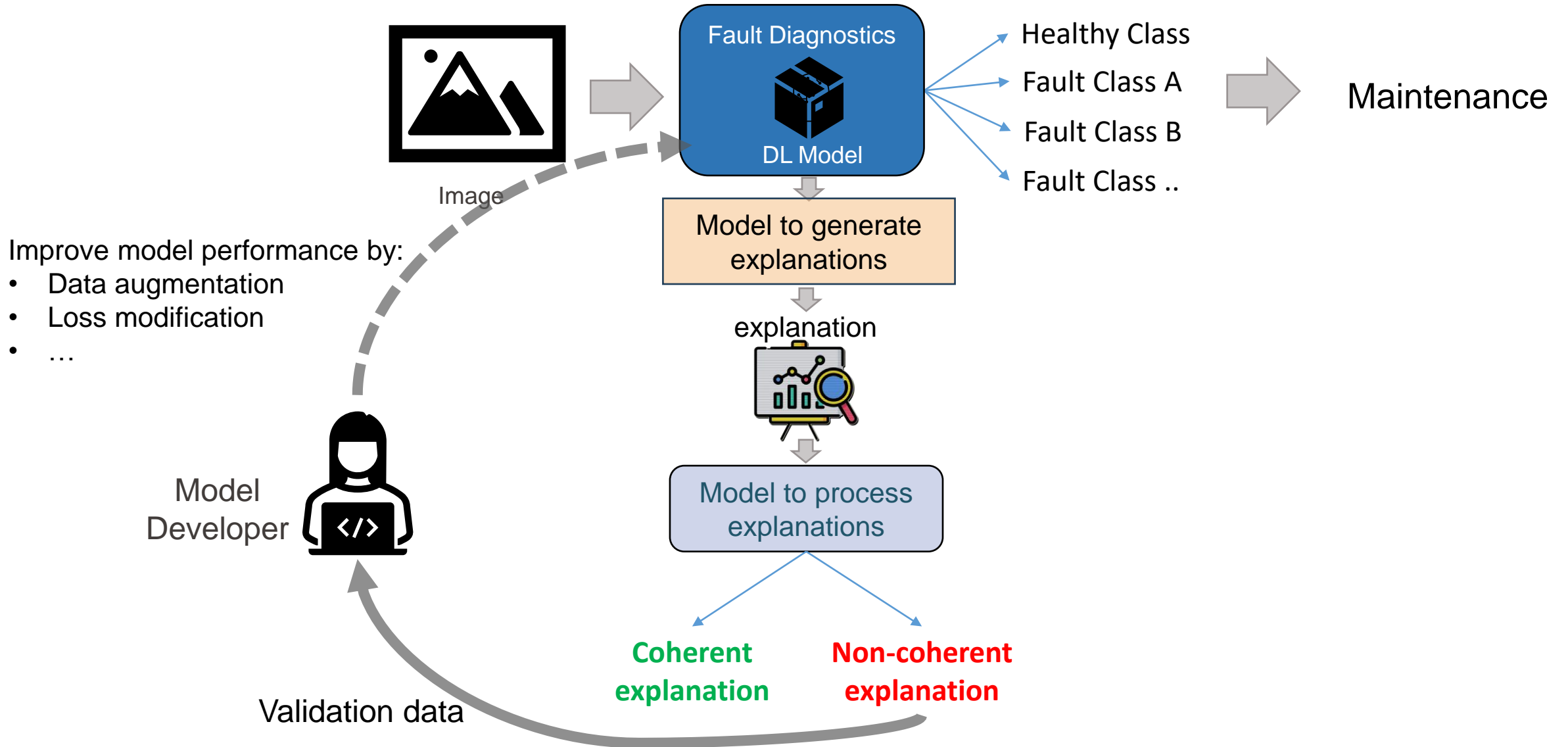
Case Study



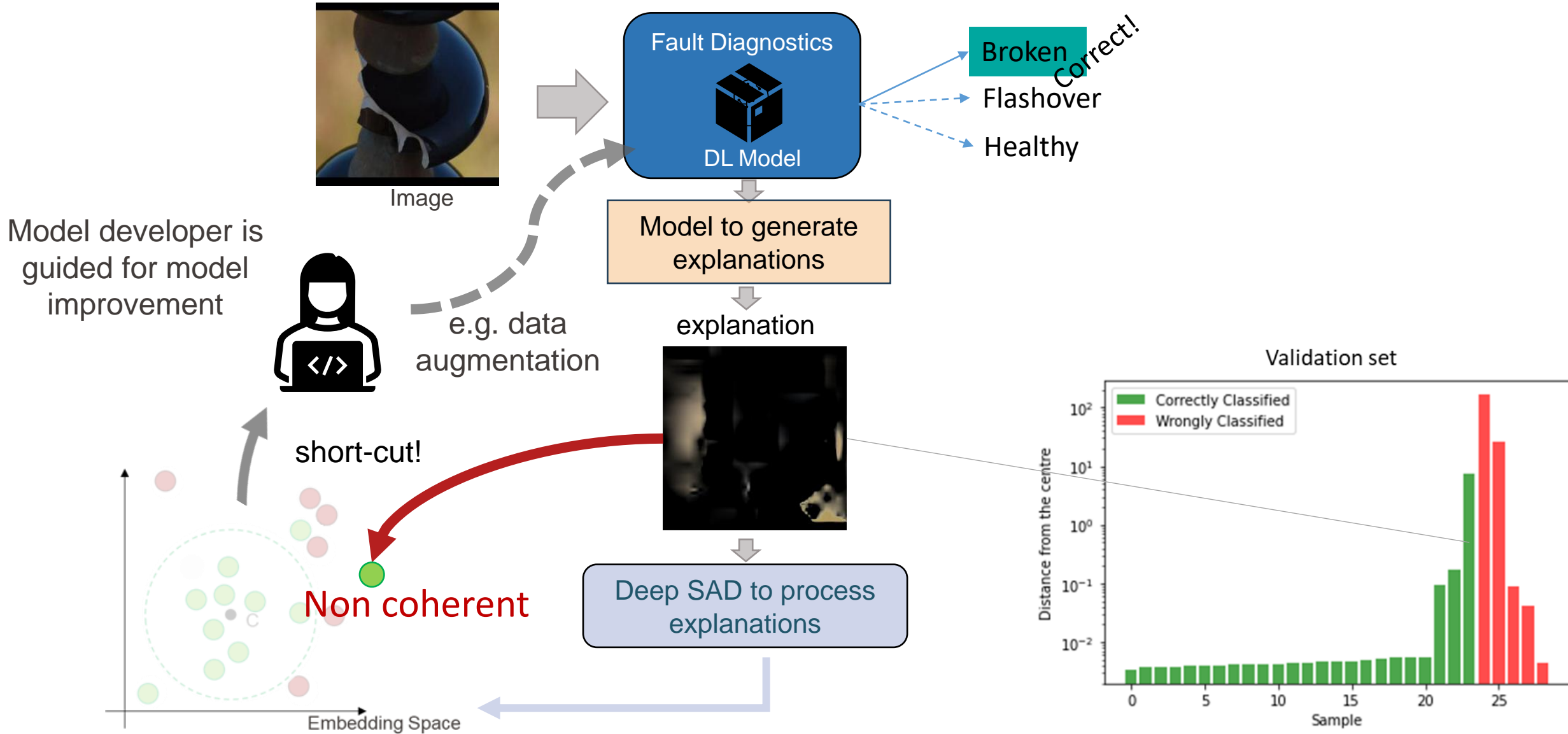
Select all the images assigned to one class



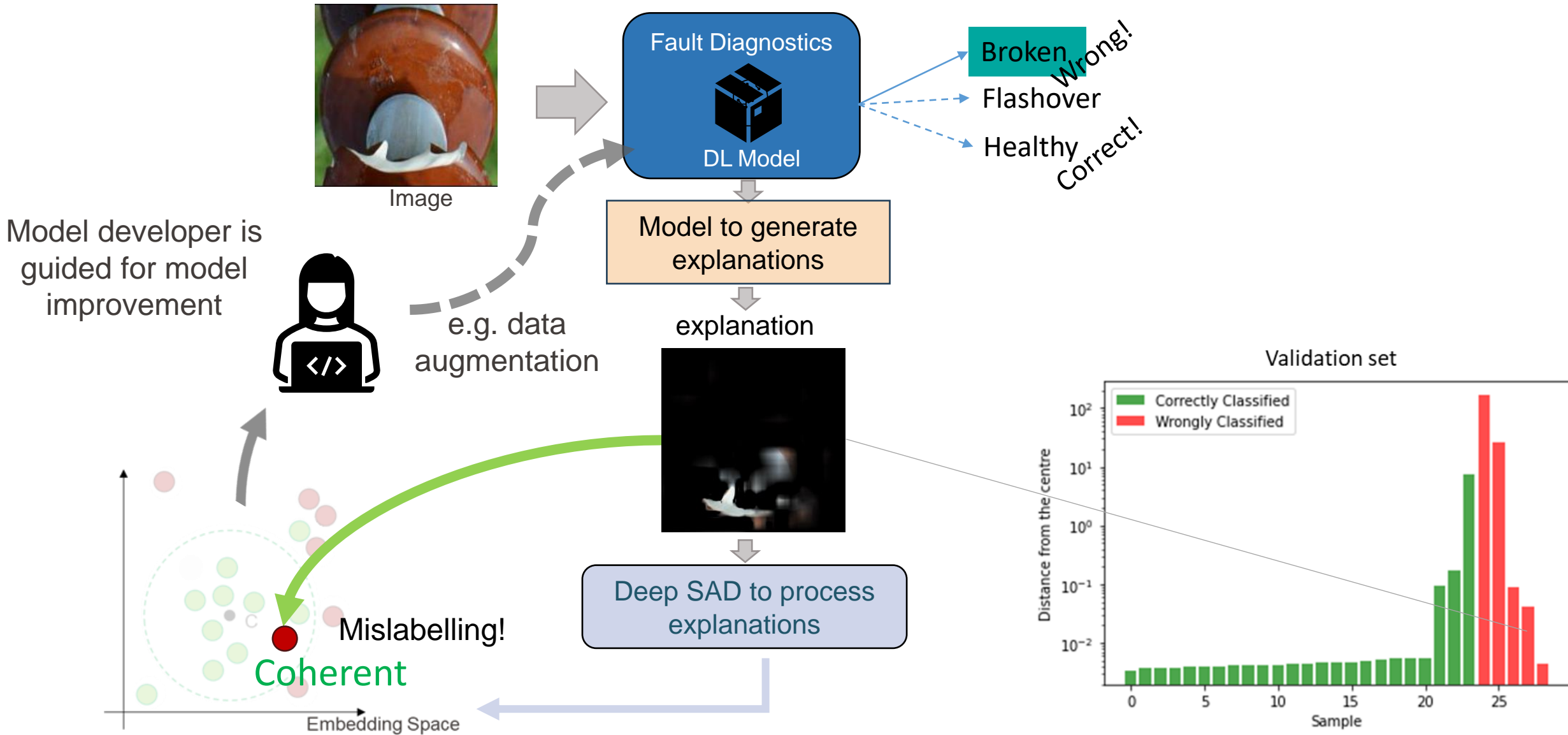
Relevance: Why is it Useful? (1)



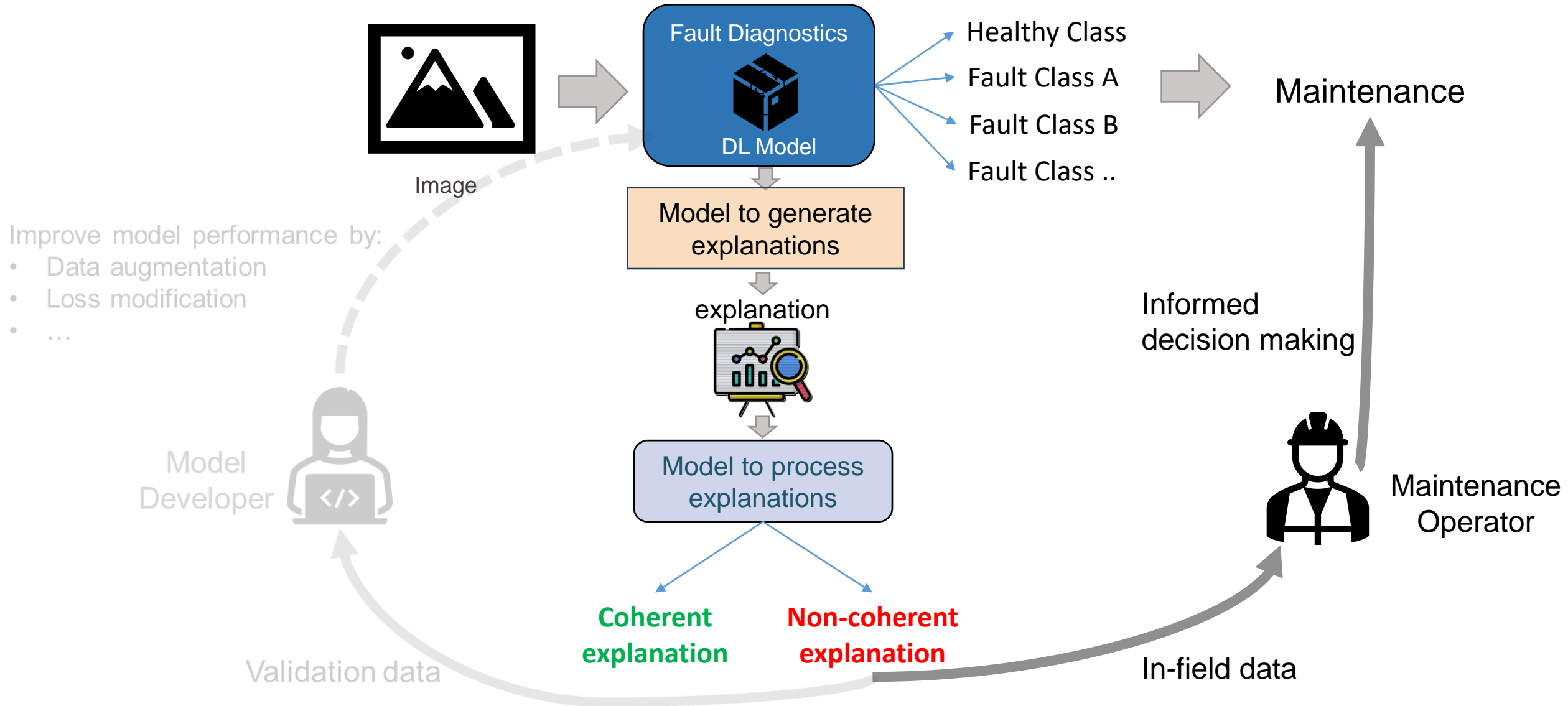
Results: Proposed Approach on Validation Set



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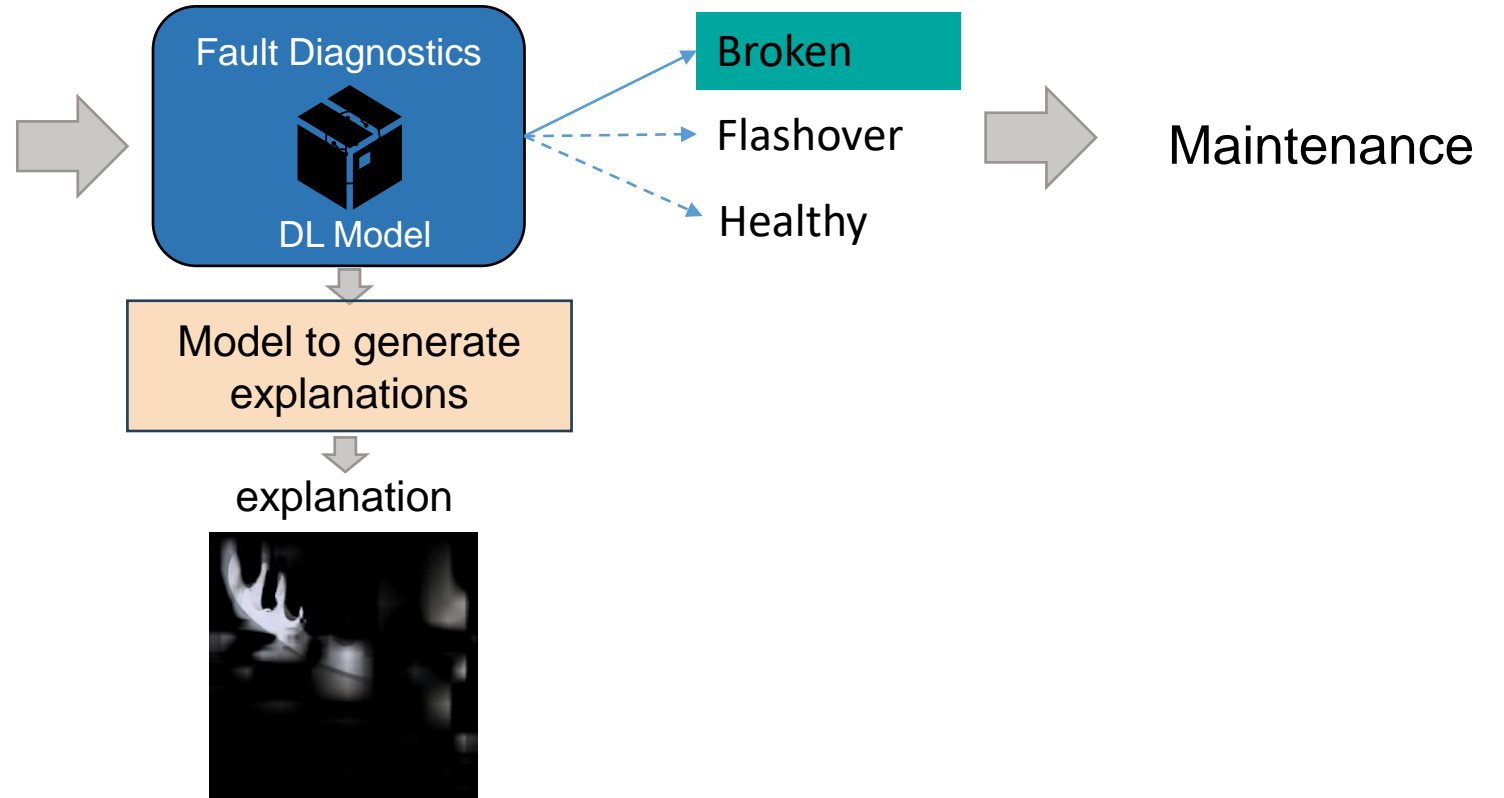
Relevance: Why is it Useful? (2)



Results: DL model

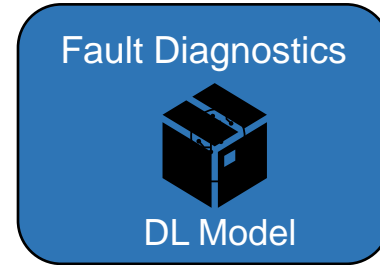
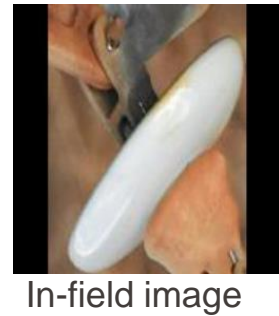


In-field image



Accuracy of DL model	89.20%
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Results: Proposed Approach In-field Application



Broken

Flashover

Healthy

Maintenance

Model to generate explanations

explanation



Broken

Flashover

Healthy

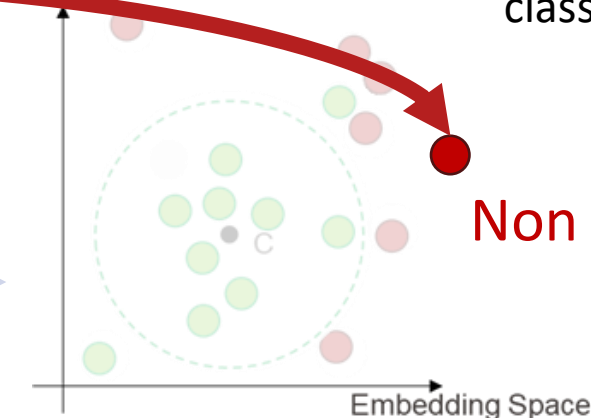
Operator is asked to correct the DL model classification

Accuracy of DL model	89.20%
Fraction of explanations that is revised by experts	19.52%
Accuracy of the proposed approach	94.87%

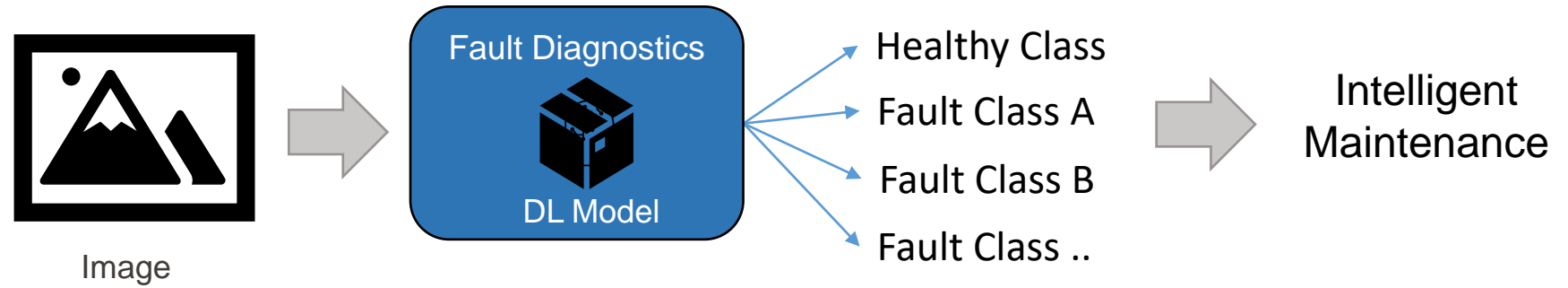
+5.67%



Deep SAD to process explanations



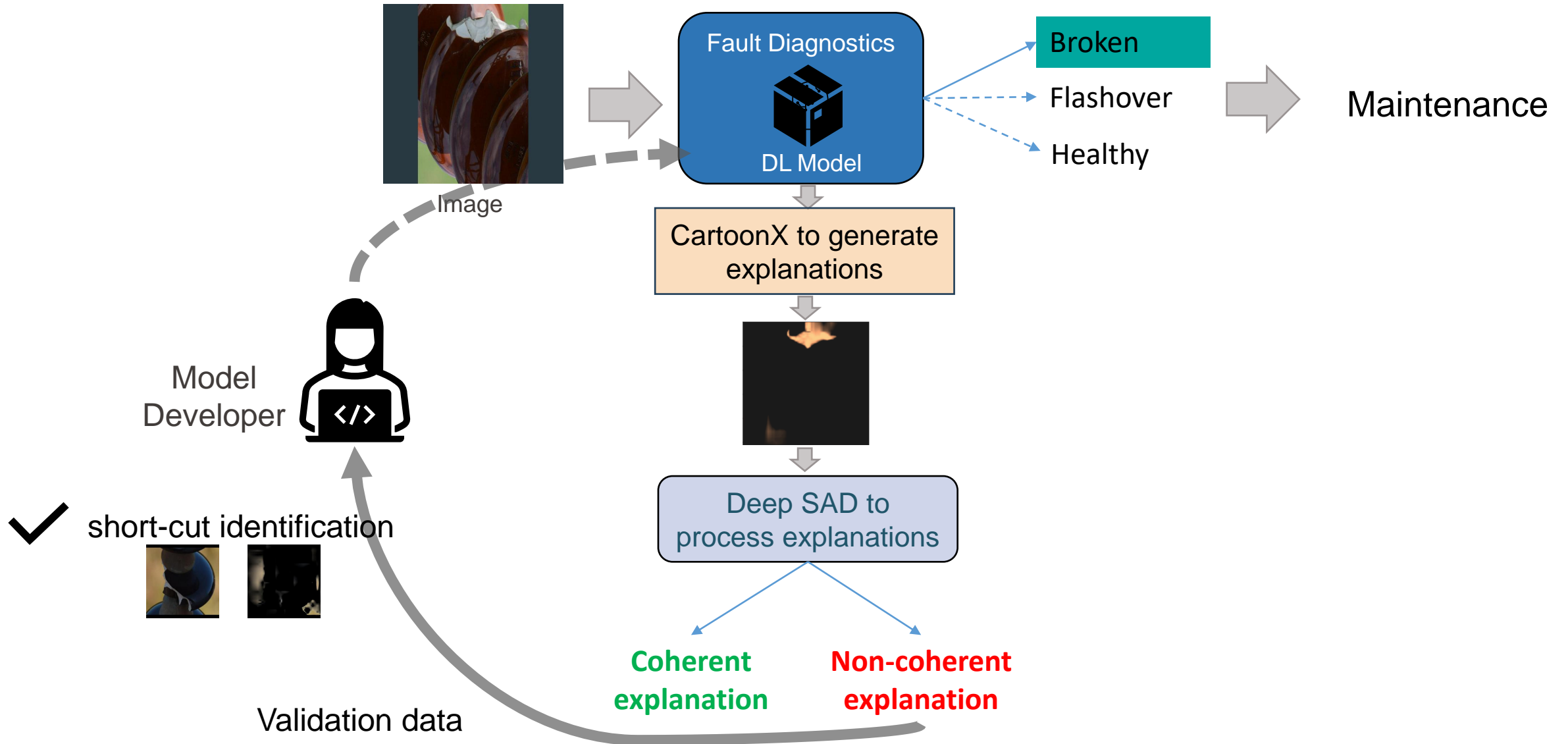
Conclusion



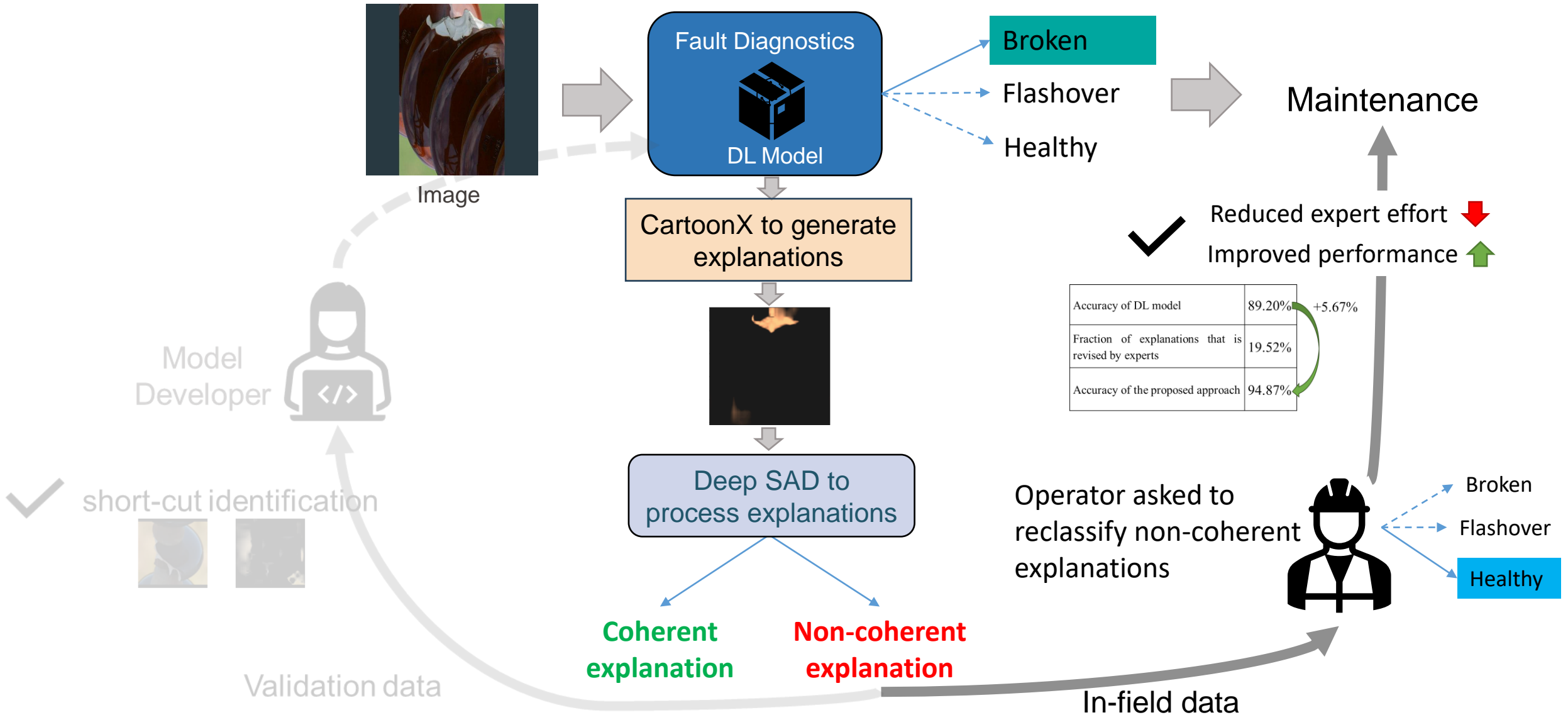
Challenges:

- Black Box
- In-field performance drop

Conclusion



Conclusion



Conclusion

Future Works:

Explanation-based performance improvement

